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: August 23, 2011 : AK8CECHZCSB

# **RADIO TEST REPORT**

Test Report No.: 31KE0011-HO-01-A

**Applicant** : Sony Computer Entertainment Inc.

Type of Equipment : Wireless Controller

Model No. : CECH-ZCS1U

FCC ID : AK8CECHZCSB

Test regulation : FCC Part 15 Subpart C: 2011

Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.

- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the above regulation.
- 4. The test results in this report are traceable to the national or international standards.

5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test:

June 23 to August 10, 2011

Representative test engineer:

Takumi Shimada Engineer of WiSE Japan, UL Verification Service

Approved by:

Mitsuru Fujimura Leader of WiSE Japan, UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. \*As for the range of Accreditation in NVLAP, you may refer to the WEB address,

http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap

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## **SECTION 1: Customer information**

Company Name	Sony Computer Entertainment Inc.
Brand Name	SONY
Address	1-7-1 Konan, Minato-ku, Tokyo, 108-0075 Japan
Telephone Number	+81-3-6748-6333
Facsimile Number	+81-3-6748-6383
Contact Person	Akiko Tsukada

## **SECTION 2:** Equipment under test (E.U.T.)

### 2.1 Identification of E.U.T.

Type of Equipment	Wireless Controller
Model No	CECH-ZCS1U
Serial No	DVT-20034T for Conducted Emission/Radiated Emission Tests
	DVT-20060T for Antenna Terminal Conducted Test
Country of Manufacture	China
Receipt Date of Sample	June 10, 2011
Condition of EUT	Engineering prototype
	(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	No modification by the test lab.

## 2.2 Product Description

Model No: CECH-ZCS1U (referred to as the EUT in this report) is the Wireless Controller.

**Product Specification** 

Clock frequency in the	32MHz, 26MHz, 16MHz, 8MHz
system	
Operating Temperature	5-35 deg. C
Power Supply	DC5V (USB Bus Power)
Battery Supply	DC3.7V
Size	138 x 42 mm
Weight	95 g

### Radio Specification: Bluetooth (Ver. 2.0+EDR)

( , 617 270 ; 22 17)
Transceiver
2402-2480MHz
FHSS (GFSK, $\pi/4$ DQPSK, 8DPSK)
1MHz & 1MHz
Synthesizer
DC2.8, 3.2V
Printed antenna
0.6dBi max

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## **SECTION 3: Test specification, procedures & results**

### 3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2011, final revised on July 8, 2011 and effective August

8, 2011

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.247 Operation within the bands 902-928MHz,

2400-2483.5MHz, and 5725-5850MHz

#### 3.2 Procedures and results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 IC: RSS-Gen 7.2.4	<b>QP</b> 14.9dB, 0.20023MHz, L <b>AV</b> 12.0dB, 0.20023MHz, L	Complied	-
Carrier Frequency Separation	DA 00-705	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (b)		Complied	Conducted
20dB Bandwidth	FCC: FCC Public Notice DA 00-705	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (a)		-	Conducted
Number of Hopping Frequency	DA 00-705	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)	-See data.	Complied	Conducted
Dwell time	DA 00-705	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)		Complied	Conducted
Maximum Peak Output Power	DA 00-705	FCC: Section15.247(a)(b)(1) IC: RSS-210 A8.4 (2)		Complied	Conducted
Spurious Emission & Band Edge Compliance		FCC: Section15.247(d)  IC: RSS-210 A8.5	11.1dB 24020.000MHz, AV, Horizontal	Complied	Conducted/ Radiated

<sup>\*</sup> In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

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<sup>\*</sup>The revision on July 8, 2011 does not affect the test specification applied to the EUT.

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#### FCC 15.31 (e)

This EUT provides stable voltage(DC2.8, 3.2V) constantly to RF part regardless of input voltage. Therefore, this EUT complies with the requirement.

### FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

#### 3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	-	Conducted
Bandwidth					
Receiver Spurious Emission	IC: RSS-Gen 4.10	IC: RSS-Gen 6	8.1dB	Complied	Radiated
_			2442.500MHz, AV, Hori	-	

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

#### **EMI**

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission
(semi-	( <u>+</u> dB)
anechoic	150kHz-30MHz
chamber)	
No.1	3.1dB
No.2	3.3dB
No.3	3.7dB
No.4	3.2dB

Test room	Radiated emission						
(semi-		(3m*)(+dB)			(1m*)(+dB)		$(0.5\text{m}^*)(\underline{+}\text{dB})$
anechoic	9kHz	30MHz	300MHz	1GHz	10GHz	18GHz	26.5GHz
chamber)	-30MHz	-300MHz	-1GHz	-10GHz	-18GHz	-26.5GHz	-40GHz
No.1	3.5dB	5.1dB	5.2dB	4.8dB	5.1dB	4.4dB	4.3dB
No.2	4.0dB	5.1dB	5.2dB	4.8dB	5.0dB	4.3dB	4.2dB
No.3	4.2dB	4.7dB	5.2dB	4.8dB	5.0dB	4.5dB	4.2dB
No.4	4.0dB	5.0dB	5.1dB	4.8dB	5.0dB	5.1dB	4.2dB

<sup>\*3</sup>m/1m/0.5m = Measurement distance

Power meter ( <u>+</u> dB)				
Below 1GHz	Above 1GHz			
1.0dB	1.0dB			

Antenna terminal conducted emission		Antenna terminal conducted emission		Channel power	
and	Power density (-	<u>+</u> <b>dB</b> )	( <u>+</u> dB)		( <u>+</u> dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

#### Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

### Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

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#### 3.5 Test Location

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Telephone: +81 596 24 8116 Facsimile: +81 596 24 8124

	FCC	IC Registration	Width x Depth x	Size of	Other
	Registration Number	Number	Height (m)	reference ground plane (m) / horizontal conducting plane	rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

<sup>\*</sup> Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

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## **SECTION 4: Operation of E.U.T. during testing**

#### 4.1 Operating Mode(s)

Bluetooth (BT): Transmitting (Tx), Payload: PRBS9

Receiving (Rx)

Inquiry

Details of Operating Mode(s)

Test Item	Mode	Tested frequency
Conducted Emission,	Tx (Hopping off) DH5, 3DH5	2402MHz
Spurious Emission		2441MHz
(Conducted)		2480MHz
Carrier Frequency Separation	Tx (Hopping on) DH5, 3DH5	2402MHz
	Inquiry	2441MHz
		2480MHz
20dB Bandwidth	Tx (Hopping off) DH5, 3DH5	2402MHz
	Inquiry	2441MHz
		2480MHz
Number of Hopping Frequency	Tx (Hopping on) DH5, 3DH5	-
	Inquiry	
Dwell time	Tx (Hopping on),	-
	-DH1, DH3, DH5	
	-3DH1, 3DH3, 3DH5	
	Inquiry	
Maximum Peak Output Power	Tx (Hopping off) DH5, 3DH5	2402MHz
	Inquiry	2441MHz
		2480MHz
Band Edge Compliance	Tx DH5, 3DH5	2402MHz
(Conducted)	-Hopping on	2480MHz
	-Hopping off	
99% Occupied Bandwidth	Tx DH5, 3DH5	2402MHz
	-Hopping on	2441MHz
	-Hopping off	2480MHz
Spurious Emission	Tx (Hopping off) DH5, 3DH5	2402MHz
(Radiated)		2441MHz
		2480MHz
	Rx	2441MHz

<sup>\*</sup>As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test)

Power settings: [Antenna Terminal Conducted test]

BDR: Ext.=255, Int.=44 EDR: Ext.=255, Int.=47

[Conducted Emission/Radiated Emission]

BDR: Ext.=255, Int.=44 EDR: Ext.=255, Int.=46

Software: CSR BlueSuite BlueTest 3 Version 2.1.0.0

CSR BlueSuite BtCliCtrl Version 2.1.0.0 (Inquiry mode only)

\*This setting of software is the worst case.

Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.

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<sup>\*</sup>EUT has the power settings by the software as follows;

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## 4.2 Configuration and peripherals

This page has been submitted for a separate exhibit.

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### **SECTION 5: Conducted Emission**

#### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector : QP and AV
Measurement range : 0.15-30MHz
Test data : APPENDIX
Test result : Pass

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# **SECTION 6: Radiated Spurious Emission**

#### **Test Procedure**

EUT was placed on a urethane platform of nominal size, 1.0m by 0.5m, raised 0.8m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

#### Test Antennas are used as below:

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

In any 100kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 5 of RSS-Gen 7.2.5 (IC) and outside the restricted band of FCC15.205 / Table 3 of RSS-Gen 7.2.2 (IC).

Frequency	Below 1GHz	Above 1GHz	20dBc	
Instrument used	Test Receiver	Spectrum Analyzer	Spectrum Analyzer	
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz	RBW: 1MHz	RBW: 100kHz
		VBW: 3MHz	VBW: 10Hz	VBW: 300kHz (S/A)
			or	
		RBW: 1MHz		
			VBW: 270Hz *1)	
Test Distance	3m	3m (below 10GHz),		3m (below 10GHz),
		1m*2) (above 10GHz	1m*2) (above 10GHz)	

<sup>\*1)</sup> Used for the band edge of the carrier and the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (see Apendix).

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30M-25GHz
Test data : APPENDIX
Test result : Pass

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<sup>\*2)</sup> Distance Factor:  $20 \times \log (3.0 \text{m}/1.0 \text{m}) = 9.5 \text{dB}$ 

<sup>-</sup> The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

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## **SECTION 7: Antenna Terminal Conducted Tests**

#### **Test Procedure**

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
20dB Bandwidth	3MHz	30kHz	30kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50MHz BW)
Carrier Frequency Separation	5MHz or 3MHz	100kHz	300kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	100kHz, 1MHz	300kHz, 3MHz	As necessary capture the entire dwell time per hopping channel	Peak	Max Hold	Spectrum Analyzer
Conducted Spurious	9kHz to 150kHz	200Hz	620Hz	Auto	Peak	Max Hold	Spectrum Analyzer
Emission *1)	150kHz to 30MHz	9.1kHz	27kHz				
	30MHz to 25GHz (Less or equal to 5GHz)	100kHz	300kHz				
Conducted Spurious Emission Band Edge compliance	20MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer

<sup>\*1)</sup> In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.(9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX

Test result : Pass

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